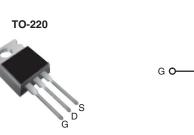


Vishay Siliconix



Power MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	900				
R _{DS(on)} (Ω)	$V_{GS} = 10 V$	3.7			
Q _g (Max.) (nC)	78				
Q _{gs} (nC)	10				
Q _{gd} (nC)	42				
Configuration	Single				



N-Channel MOSFET

FEATURES

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- Fast Switching
- Ease of Paralleling
- Simple Drive Requirements
- Lead (Pb)-free Available

DESCRIPTION

Third generation MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 package is universially preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220 contribute to its wide acceptance throughout the industry.

ORDERING INFORMATION	
Package	TO-220
Lead (Pb)-free	IRFBF30PbF
	SiHFBF30-E3
SnPb	IRFBF30
	SiHFBF30

ABSOLUTE MAXIMUM RATINGS $T_C = 25 \degree C$, unless otherwise noted							
PARAMETER			SYMBOL	LIMITE	UNIT		
Drain-Source Voltage			V _{DS}	900	v		
Gate-Source Voltage			V _{GS}	± 20			
Continuous Drain Current	V _{GS} at 10 V	T _C = 25 °C	- I _D	3.6			
	VGS at 10 V	$T_C = 100 ^{\circ}C$		2.3	А		
Pulsed Drain Current ^a			I _{DM}	14			
Linear Derating Factor			1.0	W/°C			
Single Pulse Avalanche Energy ^b			E _{AS}	250	mJ		
Repetitive Avalanche Current ^a			I _{AR}	3.6	А		
Repetitive Avalanche Energy ^a			E _{AR}	13	mJ		
Maximum Power Dissipation	T _C =	25 °C	PD	125	W		
Peak Diode Recovery dV/dt ^c		dV/dt	1.5	V/ns			
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to + 150	°C			
Soldering Recommendations (Peak Temperature)	for 10 s			300 ^d	U U		
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in		
				1.1	N · m		

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. V_{DD} = 50 V, starting T_J = 25 °C, L = 36 mH, R_G = 25 Ω , I_{AS} = 3.6 A (see fig. 12).

c. $I_{SD} \leq 3.6$ A, $dI/dt \leq 70$ A/µs, $V_{DD} \leq 600, \, T_J \leq 150 \ ^{\circ}C.$

d. 1.6 mm from case.

* Pb containing terminations are not RoHS compliant, exemptions may apply



Vishay Siliconix



THERMAL RESISTANCE RAT								
PARAMETER	SYMBOL	TYP. MAX.			UNIT			
Maximum Junction-to-Ambient	R _{thJA}	- 62 0.50 -						
Case-to-Sink, Flat, Greased Surface	R _{thCS}				°C/W			
Maximum Junction-to-Case (Drain)	R _{thJC}	-		1.0				
SPECIFICATIONS T _J = 25 °C, 1	unless otherv	vise noted						
PARAMETER	SYMBOL		T CONDITI	ONS	MIN.	TYP.	MAX.	UNIT
Static						•	•	1
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} :	= 0 V, I _D = 2	50 μA	900	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C,	$I_D = 1 \text{ mA}$	-	1.1	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \mu A$			2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}	-	$V_{GS} = \pm 20^{\circ}$		-	-	± 100	nA
Ū.			= 900 V, V _{GS}		-	-	100	<u> </u>
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 720 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{\text{J}} = 125 ^{\circ}\text{C}$		-	-	500	μA	
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D	= 2.2 A ^b	-	-	3.7	Ω
Forward Transconductance	g _{fs}	V _{DS} =	100 V, I _D =	2.2 A ^b	2.3	-	-	S
Dynamic						•	•	1
Input Capacitance	C _{iss}	$V_{GS} = 0 V,$ $V_{DS} = 25 V,$ f = 1.0 MHz, see fig. 5		-	1200	-	pF	
Output Capacitance	Coss			-	320	-		
Reverse Transfer Capacitance	C _{rss}			-	200	-		
Total Gate Charge	Qg				-	-	78	
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V	$V_{GS} = 10 \text{ V} \qquad \begin{array}{c} I_D = 3.6 \text{ A}, V_{DS} = \\ \text{see fig. 6 and} \end{array}$		-	-	10	nC
Gate-Drain Charge	Q _{gd}				-	-	42	
Turn-On Delay Time	t _{d(on)}				-	14	-	
Rise Time	t _r	Voo =	450 V. In =	3.6 A.	-	25	-	1
Turn-Off Delay Time	t _{d(off)}	V_{DD} = 450 V, I _D = 3.6 A, R _G = 12 Ω, R _D = 120 Ω, see fig. 10 ^b			-	90	-	ns
Fall Time	t _f	-			-	30	-	-
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	nH	
Internal Source Inductance	L _S			-	7.5	-		
Drain-Source Body Diode Characteristic	s							
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the		-	-	3.6	A	
Pulsed Diode Forward Current ^a	I _{SM}	integral reverse p - n junction diode			-	-		14
Body Diode Voltage	V_{SD}	$T_J = 25 \ ^\circ C, \ I_S = 3.6 \ A, \ V_{GS} = 0 \ V^b$			-	-	1.8	V
Body Diode Reverse Recovery Time	t _{rr}	$T_J = 25 \text{ °C}, I_F = 3.6 \text{ A}, dI/dt = 100 \text{ A}/\mu\text{s}^{b}$		-	430	650	ns	
Body Diode Reverse Recovery Charge	Q _{rr}			-	1.4	2.1	μC	
Forward Turn-On Time	t _{on}	Intrinsic tu	ırn-on time i	s negligible (turn	-on is dor	ninated by	v Ls and I	<u> </u>

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width \leq 300 µs; duty cycle \leq 2 %.



Vishay Siliconix

TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

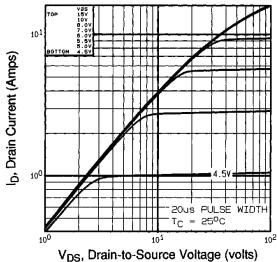


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

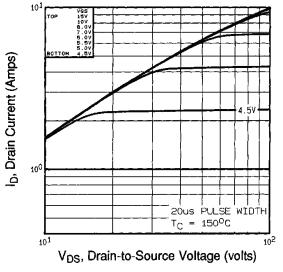
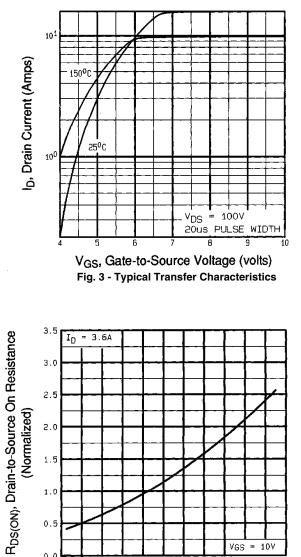


Fig. 2 -Typical Output Characteristics, T_C = 150 °C



0.0 -60 -40 -20 0 20 40 60 80 100 120 140 160 T_J, Junction Temperature (°C) Fig. 4 - Normalized On-Resistance vs. Temperature

VGS = 10V

Vishay Siliconix



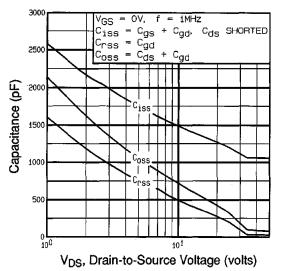


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

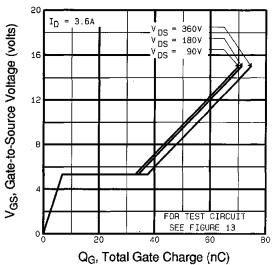


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

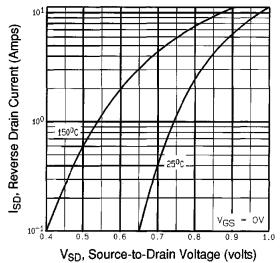
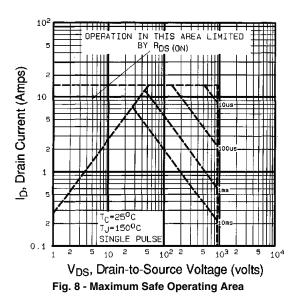


Fig. 7 - Typical Source-Drain Diode Forward Voltage





Vishay Siliconix

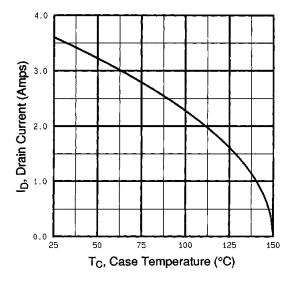


Fig. 9 - Maximum Drain Current vs. Case Temperature

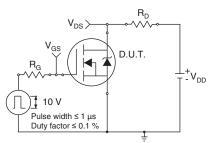


Fig. 10a - Switching Time Test Circuit

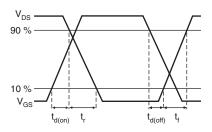
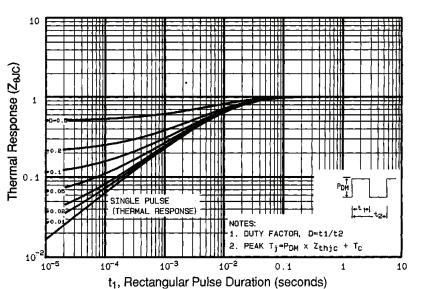


Fig. 10b - Switching Time Waveforms





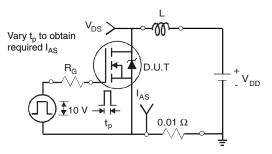


Fig. 12a - Unclamped Inductive Test Circuit

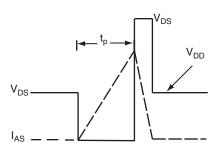
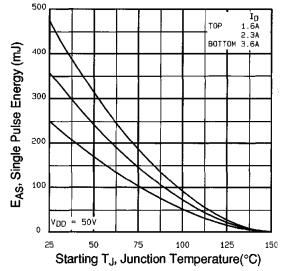
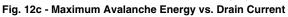


Fig. 12b - Unclamped Inductive Waveforms

Vishay Siliconix







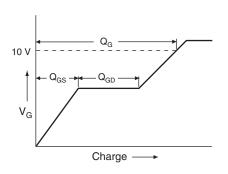
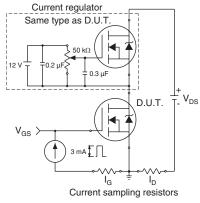
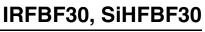


Fig. 13a - Basic Gate Charge Waveform

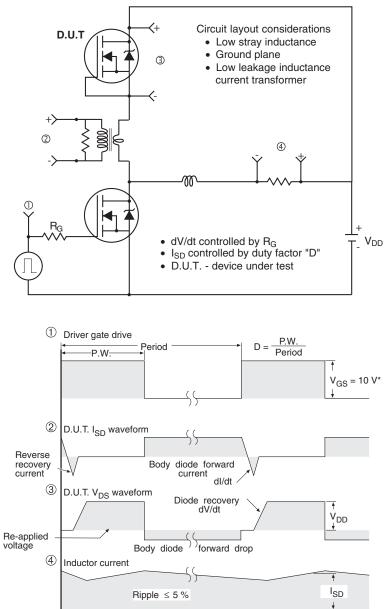






Vishay Siliconix





Peak Diode Recovery dV/dt Test Circuit

* $V_{GS} = 5 V$ for logic level 3 V drive devices

Fig. 14 -For N-Channel

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see http://www.vishay.com/ppg?91122.



Vishay

Disclaimer

All product specifications and data are subject to change without notice.

Vishay Intertechnology, Inc., its affiliates, agents, and employees, and all persons acting on its or their behalf (collectively, "Vishay"), disclaim any and all liability for any errors, inaccuracies or incompleteness contained herein or in any other disclosure relating to any product.

Vishay disclaims any and all liability arising out of the use or application of any product described herein or of any information provided herein to the maximum extent permitted by law. The product specifications do not expand or otherwise modify Vishay's terms and conditions of purchase, including but not limited to the warranty expressed therein, which apply to these products.

No license, express or implied, by estoppel or otherwise, to any intellectual property rights is granted by this document or by any conduct of Vishay.

The products shown herein are not designed for use in medical, life-saving, or life-sustaining applications unless otherwise expressly indicated. Customers using or selling Vishay products not expressly indicated for use in such applications do so entirely at their own risk and agree to fully indemnify Vishay for any damages arising or resulting from such use or sale. Please contact authorized Vishay personnel to obtain written terms and conditions regarding products designed for such applications.

Product names and markings noted herein may be trademarks of their respective owners.